Search	Notes	

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/614,875	SATOH ET AL.	
Ì	Examiner	Art Unit	
	John Q. Nguyen	3654	

	SEARCHED			
Class	Subclass	Date	Examiner	
242	338.1 338.3 343 348	10/5/2005	JN	
360	132	10/5/2005	JN	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
interferen	search, see ce search tout	10/5/2005	JN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR